

**Amendments to the Claims:**

The following listing of claims will replace all prior versions, and listings, of claims in the application:

1. (Currently Amended) An image quality assessment determination method ~~comprising the steps of, method, comprising:~~  
providing a reference/test ~~image~~ image, on a substrate, having at least a portion  
with a ~~predetermined~~ an intended uniform optical density;  
~~using determining, with~~ a color measuring device normally usable to  
determine spectral aspects of a reference/test ~~image to determine the~~ image, a spatial  
uniformity of ~~the~~ at least one of a transmittance ~~and/or or~~ reflectance of the reference/test  
image; and  
  
generating image spatial uniformity data based on the spatial uniformity of the  
at least one of the determined transmittance ~~and/or or~~ reflectance.
2. (Currently Amended) The method of claim 1, further comprising utilizing the  
generated spatial uniformity ~~transmittance and/or reflectance~~ data by at least one of operating  
a marking engine to modify image spatial uniformity, modifying a marking system that  
provided the reference/test image, or modifying subsequent image data.
3. (Canceled)
4. (Currently Amended) The method of ~~claim 1~~ claim 1, wherein the generated  
image spatial uniformity data generated comprises at least image reflectance and a  
corresponding position value.
5. (Currently Amended) The method of ~~claim 1~~ claim 1, ~~wherein,~~ wherein the  
color measuring device is at least one of a spectrophotometer, a colorimeter, or a  
densitometer.

6. (Currently Amended) The method of ~~claim 1~~ claim 1, ~~wherein,~~ wherein the substrate is a ~~sheet comprising at least one reference/test patch having~~ has a predetermined uniform density, sheet upon which an image is formed.

7. (Currently Amended) ~~An~~ A system for assessing and modifying the image uniformity of images produced by marking systems, assessment and modification system kit having component parts capable of being assembled in the field, the ~~kit~~ system comprising:

an image measurement device capable of ~~determining~~ determining, as a function of position, at least one of transmittance and/or reflectance as a function of position; or reflectance; and

a portable work ~~station;~~ station, capable of receiving and processing data from the image measurement device,

~~a marking system located in the field;~~

~~a substrate;~~

~~a test pattern on said substrate, the test pattern having at least one portion having a uniform optical density;~~

wherein said image measurement device is adapted to determine the spatial uniformity of the at least one of transmittance and/or or reflectance of the image; an image based on an assessment of at least one reference/test image, produced by a marking system, having at least one portion having an intended uniform optical density.

8. (Currently Amended) The ~~kit~~ system of claim 7, wherein said image measurement device communicates the determined ~~transmittance and/or reflectance~~ spatial uniformity to said portable work station; and

wherein said portable work station utilizes the determined spatial ~~uniformity of the transmittance and/or reflectance.~~ uniformity by at least one of operating a marking engine to

modify image spatial uniformity, modifying a marking system that provided the reference/test image, or modifying subsequent image data.